

## 1.Description

This P-Channel MOSFET has been produced using technology to deliver low  $R_{DS(ON)}$  and good switching characteristic offering superior performance in application.

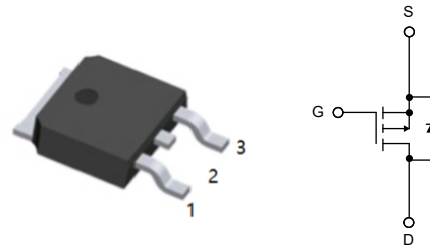
## 2.Features

- $V_{DS(V)} = -40V$
- $I_D = 32A (V_{GS} = -10V)$
- $R_{DS(ON)} < 27m\Omega (V_{GS} = -10V)$
- $R_{DS(ON)} < 35m\Omega (V_{GS} = -4.5V)$
- RoHS Compliant
- High performance trench technology for extremely low  $R_{DS(ON)}$

## 3.Pinning information

| Pin | Symbol | Description |
|-----|--------|-------------|
| 1   | G      | GATE        |
| 2   | D      | DRAIN       |
| 3   | S      | SOURCE      |

TO-252(DPAK)  
top view



## 4.Absolute Maximum Ratings $T_c = 25^\circ C$

| Parameter                                                      | Symbol         | Rating     | Units      |
|----------------------------------------------------------------|----------------|------------|------------|
| Drain to Source Voltage                                        | $V_{DS}$       | -40        | V          |
| Gate to Source Voltage                                         | $V_{GS}$       | $\pm 20$   |            |
| Drain Current -Continuous (Package limited) $T_c = 25^\circ C$ | $I_D$          | -32        | A          |
| -Continuous (Silicon limited) $T_c = 25^\circ C$ (Note 1)      |                | -40        |            |
| -Continuous $T_A = 25^\circ C$ (Note 1a)                       |                | -8.4       |            |
| -Pulsed                                                        |                | -100       |            |
| Single Pulse Avalanche Energy (Note 3)                         | $E_{AS}$       | 121        | mJ         |
| Power Dissipation $T_c = 25^\circ C$                           | $P_D$          | 69         | W          |
| Power Dissipation (Note 1a)                                    |                | 3          |            |
| Operating and Storage Junction Temperature Range               | $T_J, T_{STG}$ | -55 to 150 | $^\circ C$ |



5.Thermal Characteristics

| Parameter                                         | Symbol          | Rating | Units |
|---------------------------------------------------|-----------------|--------|-------|
| Thermal Resistance, Junction to Case              | $R_{\theta JC}$ | 1.8    | °C/W  |
| Thermal Resistance, Junction to Ambient (Note 1a) | $R_{\theta JA}$ | 40     | °C/W  |



## 6. Electrical Characteristic (T<sub>J</sub>=25°C unless otherwise noted)

| Parameter                                                | Symbol                                 | Conditions                                                                                  | Min | Typ   | Max  | Units |
|----------------------------------------------------------|----------------------------------------|---------------------------------------------------------------------------------------------|-----|-------|------|-------|
| Drain-Source Breakdown Voltage                           | BV <sub>DSS</sub>                      | I <sub>D</sub> =-250μA, V <sub>GS</sub> =0V                                                 | -40 |       |      | V     |
| Breakdown Voltage Temperature Coefficient                | $\frac{\Delta BV_{DSS}}{\Delta T_J}$   | I <sub>D</sub> =-250μA<br>Referenced to 25°C                                                |     | -33   |      | mV/°C |
| Zero Gate Voltage Drain Current                          | I <sub>DSS</sub>                       | V <sub>DS</sub> =-32V, V <sub>GS</sub> =0V                                                  |     |       | 1    | μA    |
| Gate to Source Leakage Current                           | I <sub>GSS</sub>                       | V <sub>GS</sub> =±20V, V <sub>DS</sub> =0V                                                  |     |       | ±100 | nA    |
| Gate to Source Threshold Voltage                         | V <sub>GS(th)</sub>                    | V <sub>DS</sub> =V <sub>GS</sub> , I <sub>D</sub> =-250μA                                   | -1  | -1.6  | -3   | V     |
| Gate to Source Threshold Voltage Temperature Coefficient | $\frac{\Delta V_{GS(th)}}{\Delta T_J}$ | I <sub>D</sub> =-250μA<br>Referenced to 25°C                                                |     | 4.9   |      | mV/°C |
| Static Drain to Source On Resistance                     | R <sub>DS(on)</sub>                    | V <sub>GS</sub> =-10V, I <sub>D</sub> =-8.4A                                                |     | 23    | 27   | mΩ    |
|                                                          |                                        | V <sub>GS</sub> =-4.5V, I <sub>D</sub> =-7A                                                 |     | 30    | 35   | mΩ    |
| Forward Transconductance                                 | g <sub>FS</sub>                        | V <sub>DS</sub> =-5V, I <sub>D</sub> =-8.4A                                                 |     | 23    |      | S     |
| Input Capacitance                                        | C <sub>iss</sub>                       | V <sub>DS</sub> =-20V, V <sub>GS</sub> =0V<br>f=1MHz                                        |     | 1790  | 2380 | pF    |
| Output Capacitance                                       | C <sub>oss</sub>                       |                                                                                             |     | 260   | 345  | pF    |
| Reverse Transfer Capacitance                             | C <sub>rss</sub>                       |                                                                                             |     | 140   | 205  | pF    |
| Gate Resistance                                          | R <sub>g</sub>                         | f=1MHz                                                                                      |     | 4     |      | Ω     |
| Turn-On DelayTime                                        | t <sub>D(on)</sub>                     | V <sub>DD</sub> =-20V, I <sub>D</sub> =-8.4A<br>V <sub>GS</sub> =-10V, R <sub>GEN</sub> =6Ω |     | 8     | 16   | ns    |
| Rise Time                                                | t <sub>r</sub>                         |                                                                                             |     | 15    | 27   | ns    |
| Turn-Off DelayTime                                       | t <sub>D(off)</sub>                    |                                                                                             |     | 34    | 55   | ns    |
| Fall Time                                                | t <sub>f</sub>                         |                                                                                             |     | 14    | 26   | ns    |
| Total Gate Charge                                        | Q <sub>g(TOT)</sub>                    | V <sub>DD</sub> =-20V, I <sub>D</sub> =-8.4A<br>V <sub>GS</sub> =-5V                        |     | 19    | 27   | nC    |
| Gate to Source Gate Charge                               | Q <sub>gs</sub>                        |                                                                                             |     | 5.6   |      | nC    |
| Gate to Drain "Miller" Charge                            | Q <sub>gd</sub>                        |                                                                                             |     | 6.1   |      | nC    |
| Source to Drain Diode Forward Voltage                    | V <sub>SD</sub>                        | V <sub>GS</sub> =0V, I <sub>S</sub> =-8.4A (Note 2)                                         |     | -0.85 | -1.2 | V     |
| Reverse Recovery Time                                    | t <sub>rr</sub>                        | I <sub>F</sub> =-8.4A, di/dt=100A/μs                                                        |     | 30    | 45   | ns    |
| Reverse Recovery Charge                                  | Q <sub>rr</sub>                        |                                                                                             |     | 31    | 47   | nC    |



## Notes:

1:  $R_{\theta JA}$  is sum of junction-to-case and case-to-ambient thermal resistance where the case thermal reference is defined as the solder mounting surface of the drain pins.  $R_{\theta JC}$  is guaranteed by design while  $R_{\theta JA}$  is determined by the user's board design.

a. 40°C/W when mounted on a 1 in<sup>2</sup> pad of 2 oz copper

b. 96°C/W when mounted on a minimum pad.

2: Pulse Test: Pulse Width < 300μs, Duty cycle < 2.0%.

3: Starting  $T_J=25^{\circ}\text{C}$ ,  $L=3\text{mH}$ ,  $I_{AS}=9\text{A}$ ,  $V_{DD}=40\text{V}$ ,  $V_{GS}=10\text{V}$ .



## 7.1 Typical characteristic

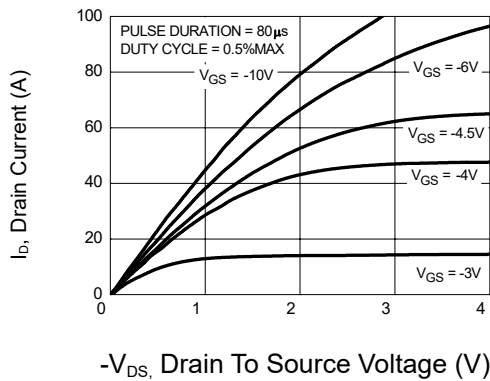


Figure 1: On-Region Characteristics

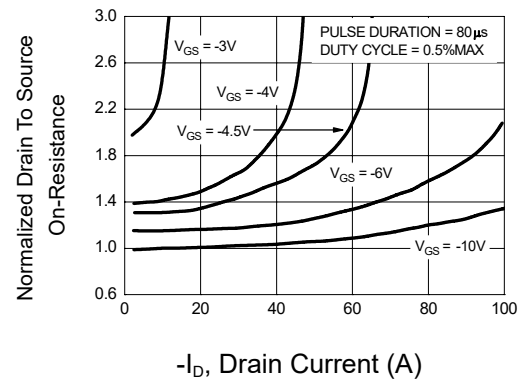


Figure 2: Normalized On-Resistance vs Drain Current and Gate Voltage

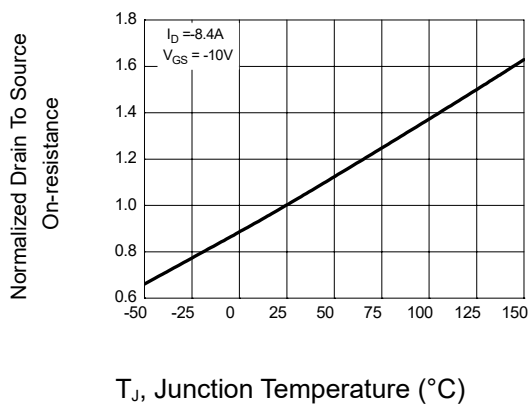


Figure 3: Normalized On Resistance vs Junction Temperature

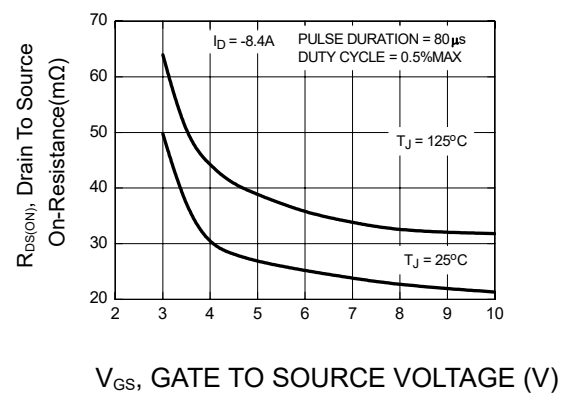


Figure 4: On-Resistance Variation with Gate-to-Source Voltage

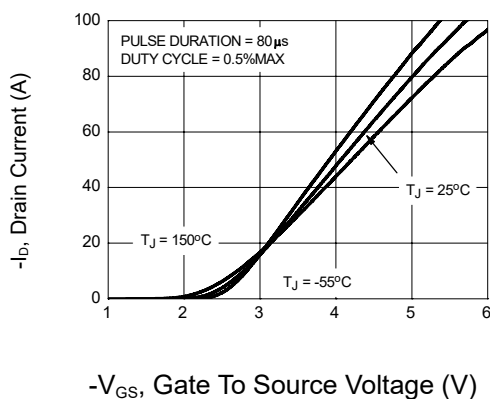


Figure 5: Transfer Characteristics

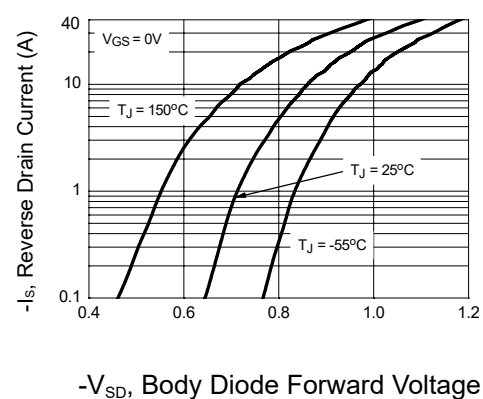


Figure 6: Source to Drain Diode Forward Voltage vs Source Current



## 7.2 Typical characteristic

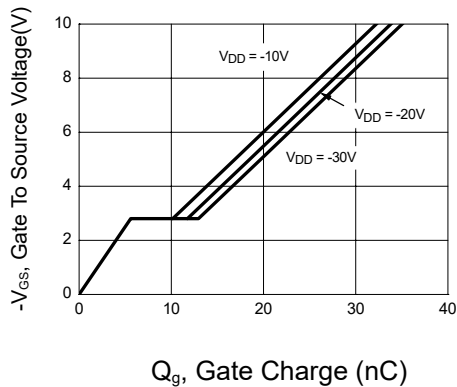


Figure 7: Gate Charge Characteristics

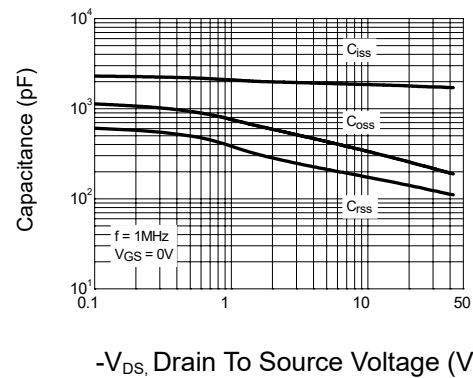


Figure 8: Capacitance vs Drain to Source Voltage

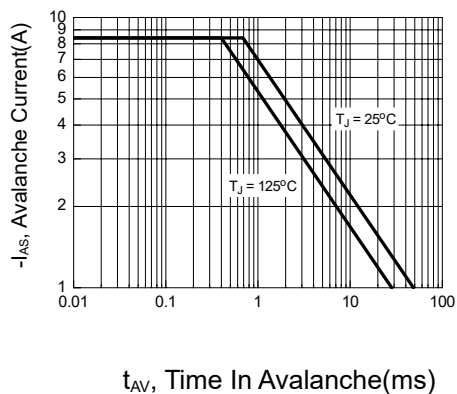


Figure 9: Unclamped Inductive Switching Capability

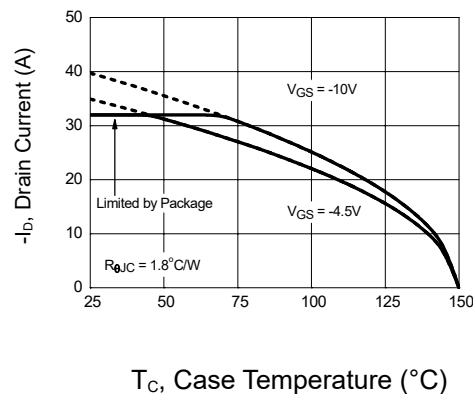


Figure 10: Maximum Continuous Drain Current vs Case Temperature

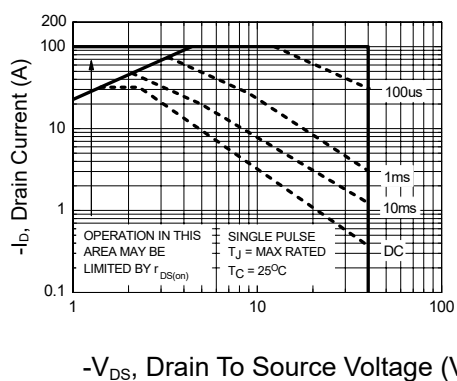


Figure 11: Forward Bias Safe Operating Area

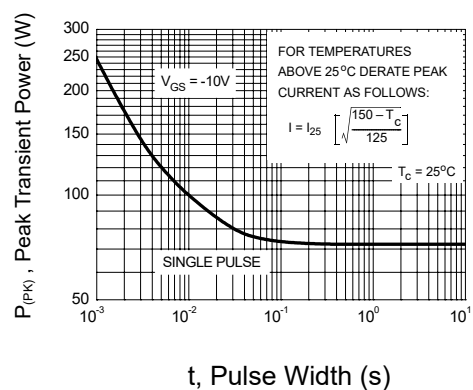
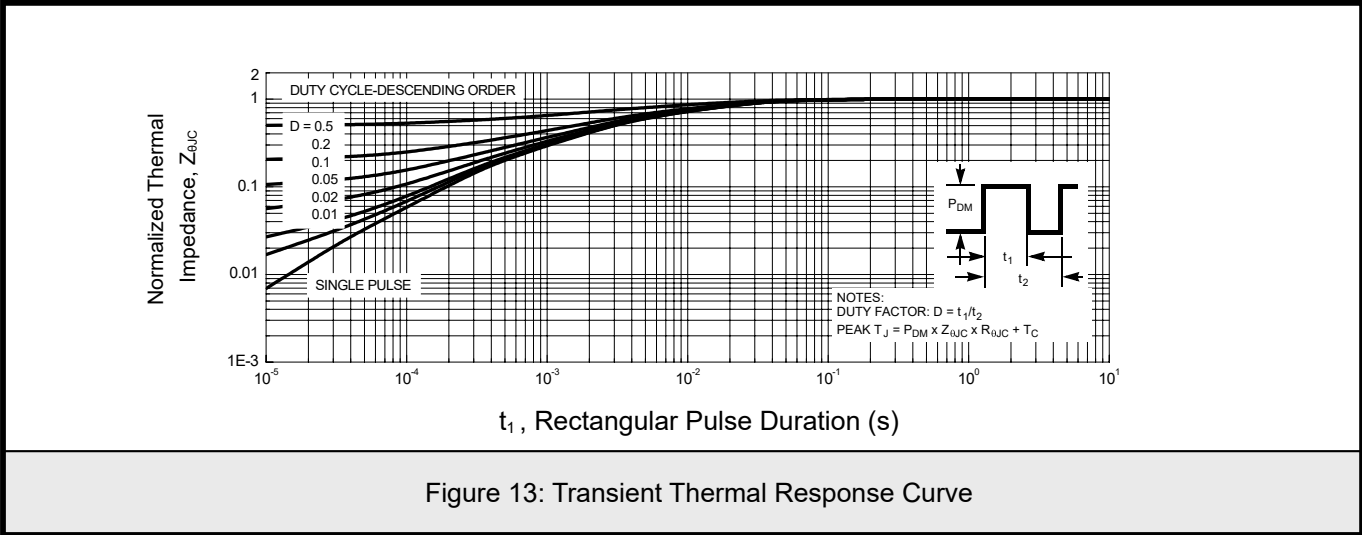


Figure 12: Single Pulse Maximum Power Dissipation

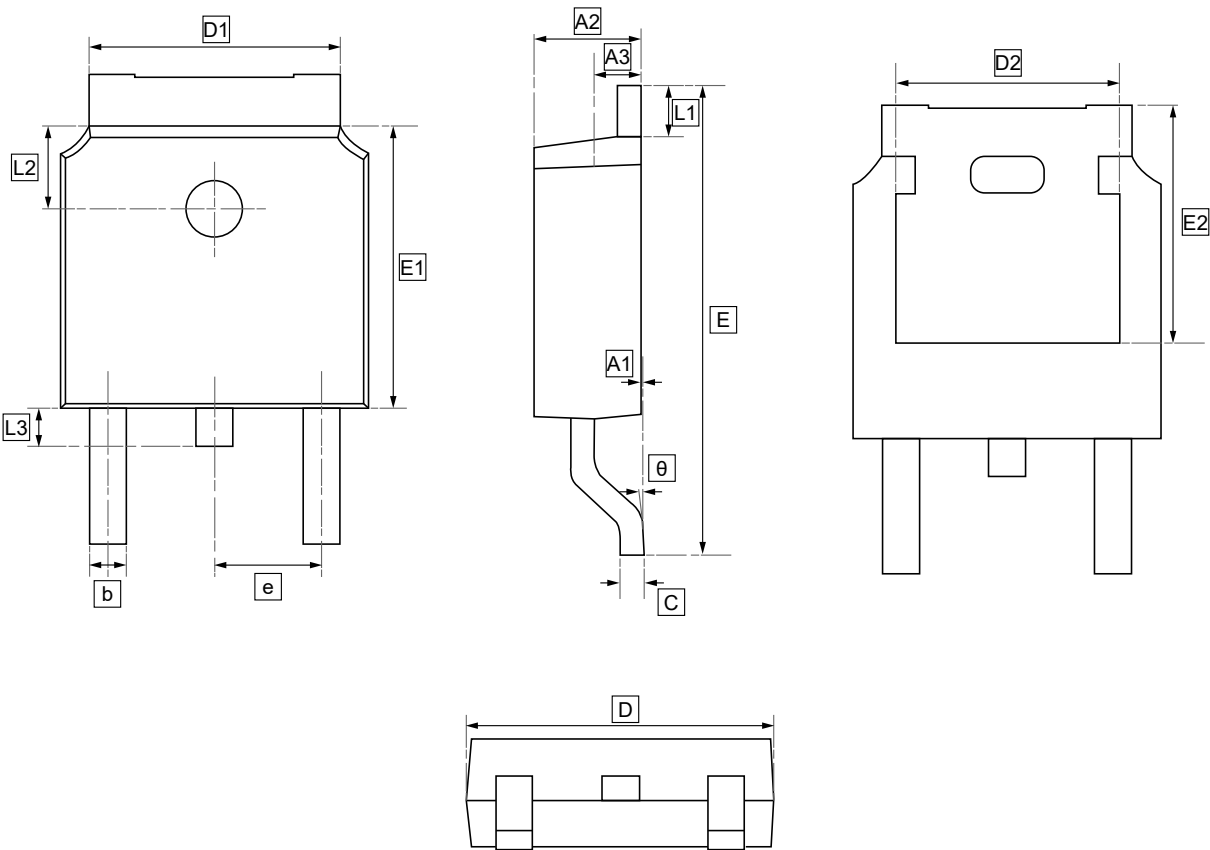


7.3Typical characteristic





8.TO-252 Package Outline Dimensions

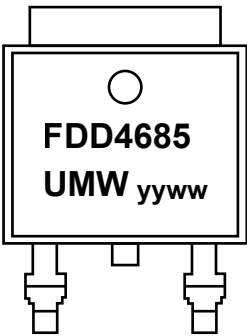


DIMENSIONS (mm are the original dimensions)

| Symbol | A1   | A2   | A3   | b    | c    | D    | D1   | D2   | E     | E1   | E2   | e     | L1   | L2   | L3   | θ    |
|--------|------|------|------|------|------|------|------|------|-------|------|------|-------|------|------|------|------|
| Min    | 0.00 | 2.18 | 0.90 | 0.65 | 0.46 | 6.35 | 4.95 | 4.32 | 9.40  | 5.97 | 5.21 | 2.286 | 0.89 | 1.70 | 0.60 | 0.00 |
| Max    | 0.13 | 2.39 | 1.10 | 0.85 | 0.61 | 6.73 | 5.46 | 4.90 | 10.41 | 6.22 | 5.38 |       | 1.27 | 1.90 | 1.00 | 8.00 |



9.Ordering information



yy: Year Code  
ww: Week Code

| Order Code  | Package | Base QTY | Delivery Mode |
|-------------|---------|----------|---------------|
| UMW FDD4685 | TO-252  | 2500     | Tape and reel |



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